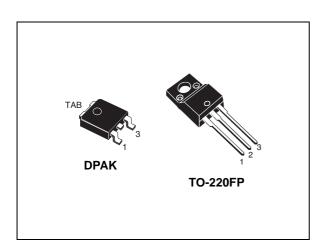


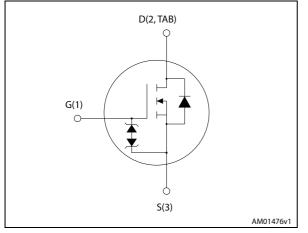
# STD5N52U, STF5N52U

Datasheet - production data

## N-channel 525 V, 1.25 Ω typ., 4.4 A UltraFASTmesh<sup>™</sup> Power MOSFETs in DPAK and TO-220FP packages



### Figure 1. Internal schematic diagram



### Features

Order codes	$V_{DS}$	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>TOT</sub>
STD5N52U	525 V	1.5 Ω	4 4 4	70 W
STF5N52U	525 V	1.5 12	4.4 A	25 W

- Outstanding dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very low R<sub>DS(on)</sub>
- Extremely low t<sub>rr</sub>

### **Applications**

• Switching applications

### Description

These devices are N-channel Power MOSFETs developed using UltraFASTmesh<sup>™</sup> technology, which combines the advantages of reduced on-resistance, Zener gate protection and very high dv/dt capability with an enhanced fast body-drain recovery diode.

#### Table 1. Device summary

Order codes	Marking	Package	Packaging
STD5N52U	5N52U	DPAK	Tape and reel
STF5N52U	511520	TO-220FP	Tube

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This is information on a product in full production.

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## 1 Electrical ratings

Cumhal	Deventer		— Unit	
Symbol	Parameter	DPAK	TO-220FP	Unit
V <sub>GS</sub>	Gate- source voltage		± 30	V
Ι <sub>D</sub>	Drain current (continuous) at $T_C = 25 \text{ °C}$		4.4	А
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C		2.8	А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)		17.6	А
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25 \text{ °C}$	70 25		W
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_J$ max)	4.4		А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$ , $I_D = I_{AR}$ , $V_{DD} = 50 \text{ V}$ )	170		mJ
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	20		V/ns
ESD	Gate-source human body model (R = 1.5 k $\Omega$ , C = 100 pF)	2.8		kV
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T <sub>C</sub> =25 °C)	2500		V
Т <sub>Ј</sub>	Operating junction temperature	55 to 150		°C
T <sub>stg</sub>	Storage temperature	-55 to 150		°C

Table 2. Absolute maximum rating
----------------------------------

1. Pulse width limited by safe operating area.

2. I\_{SD}  $\leq$  4.4 A, di/dt  $\leq$  400 A/ $\mu$ s, peak V<sub>DS</sub>  $\leq$  V<sub>(BR)DSS</sub>

### Table 3. Thermal data

Symbol	Parameter	Va	Unit	
Symbol Farameter		DPAK	TO-220FP	Onic
R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max		62.5	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb	50		°C/W

1. When mounted on 1 inch<sup>2</sup> FR-4 board, 2oz Cu



## 2 Electrical characteristics

(Tcase =25 °C unless otherwise specified).

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 1 mA	525			v
1	Zero gate voltage	V <sub>DS</sub> = 525 V			10	μA
IDSS	drain current ( $V_{GS} = 0$ )	V <sub>DS</sub> = 525 V, T <sub>C</sub> =125 °C			500	μA
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = 20 V			±10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 50 \mu\text{A}$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.2 A		1.25	1.5	Ω

### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	529	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz,	-	71	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> = 0	-	13.4	-	pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	$V_{DS} = 0$ to 420 V, $V_{GS} = 0$	-	11	-	pF
R <sub>g</sub>	Gate input resistance	f=1 MHz open drain	-	6	-	Ω
Qg	Total gate charge	V <sub>DD</sub> = 416 V, I <sub>D</sub> = 4.4 A,	-	16.9	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	4.2	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 17)	-	8.4	-	nC

1.  $C_{oss \, eq}$  time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 



	Table 0. Switching times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t <sub>d(on)</sub>	Turn-on delay time		-	11.4	-	ns	
t <sub>r</sub>	Rise time	$V_{DD} = 260 \text{ V}, I_D = 2.2 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 16)	-	13.6	-	ns	
t <sub>d(off)</sub>	Turn-off-delay time		-	23.1	-	ns	
t <sub>f</sub>	Fall time		-	15	-	ns	

Table 6. Switching times

### Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		4.4	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		17.6	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 4.4 \text{ A}, V_{GS} = 0$	-		1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4.4 A, di/dt = 100 A/µs	-	55		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 60 V	-	95		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 18)	-	3.5		А
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4.4 A, di/dt = 100 A/µs	-	120		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 60 V T <sub>J</sub> = 150 °C	-	266		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 18)	-	4.5		А

1. Pulse width limited by safe operating area

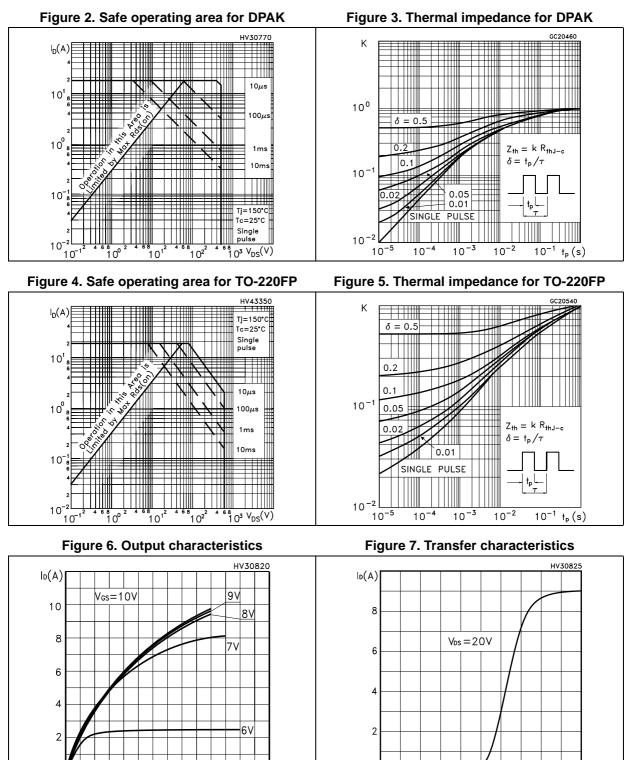
2. Pulsed: pulse duration =  $300 \,\mu$ s, duty cycle 1.5%

	Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
,	V <sub>(BR)GSO</sub> Gate-source breakdown voltage		$I_{GS} = \pm 1$ mA, $I_{D}=0$	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.



## 2.1 Electrical characteristics (curves)



0

2

4

6



8 V<sub>GS</sub>(V)

5

0

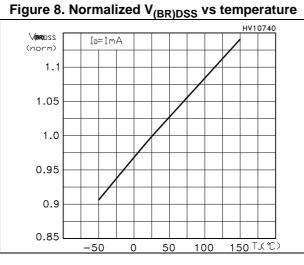
10

15

20

25

 $30 V_{DS}(V)$ 





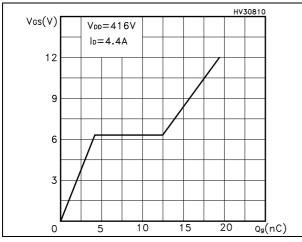


Figure 12. Normalized gate threshold voltage vs temperature

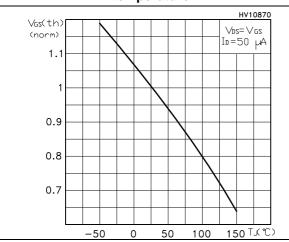
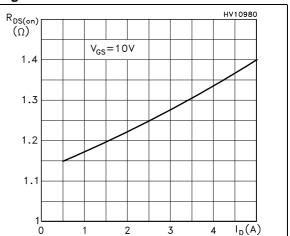


Figure 9. Static drain-source on-resistance



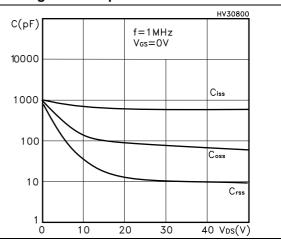
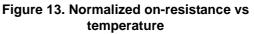
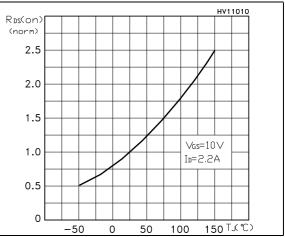


Figure 11. Capacitance variations







Vsd(V)

1

0.8

0.6

0.4

0.2

0

1

2

3

4

5

Isd(A)

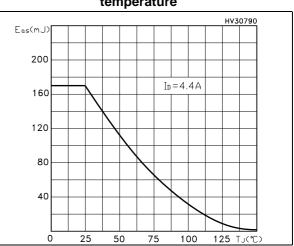
Figure 14. Source-drain diode forward characteristics

HV11020

25°C

150 °C

T\_=-50 ℃



# Figure 15. Maximum avalanche energy vs temperature



#### **Test circuits** 3

Figure 16. Switching times test circuit for resistive load

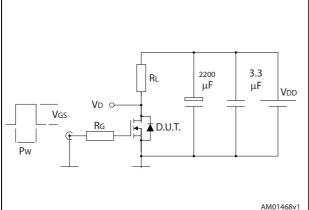


Figure 18. Test circuit for inductive load switching and diode recovery times

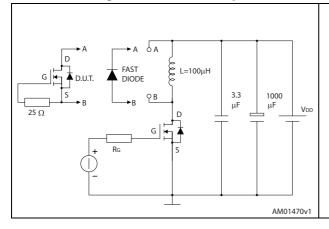
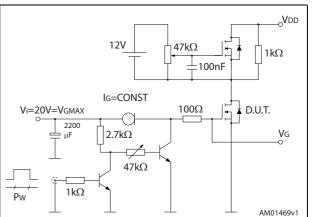


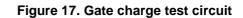
Figure 20. Unclamped inductive waveform

VD

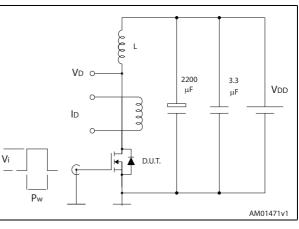
IDM

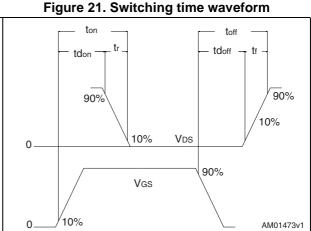
lр













V(BR)DSS



Vdd

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Vdd

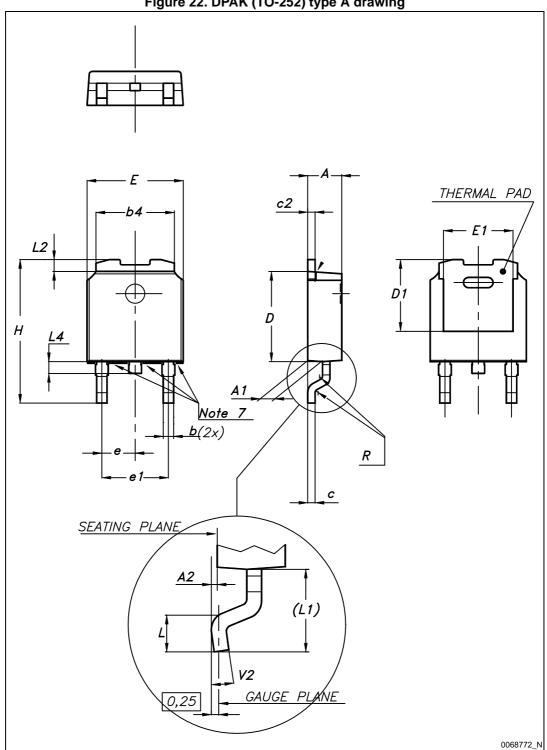
AM01472v1

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



#### DPAK, STD5N52U 4.1



### Figure 22. DPAK (TO-252) type A drawing



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	mm				
Dim. —	Min.	Тур.	Max.		
А	2.20		2.40		
A1	0.90		1.10		
A2	0.03		0.23		
b	0.64		0.90		
b4	5.20		5.40		
с	0.45		0.60		
c2	0.48		0.60		
D	6.00		6.20		
D1		5.10			
E	6.40		6.60		
E1		4.70			
е		2.28			
e1	4.40		4.60		
н	9.35		10.10		
L	1.00		1.50		
(L1)		2.80			
L2		0.80			
L4	0.60		1.00		
R		0.20			
V2	0°		8°		

Table 9. DPAK (TO-252) type A mechanical data



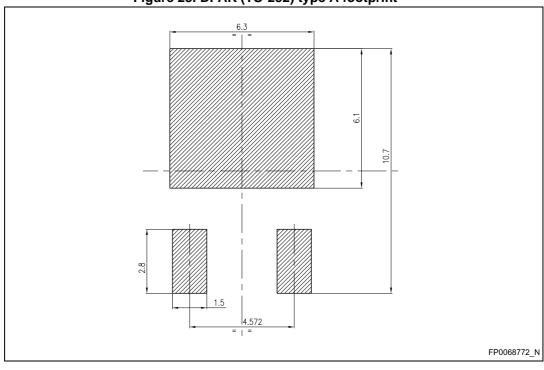
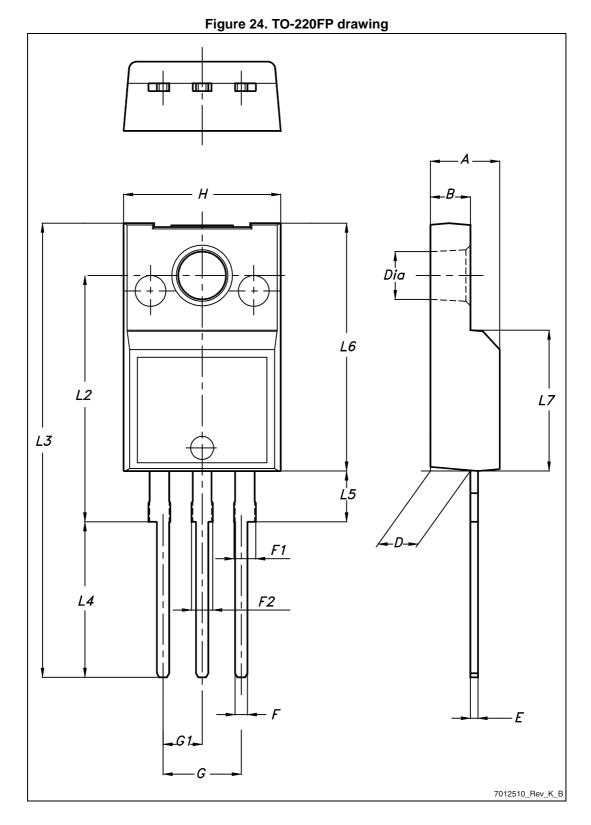


Figure 23. DPAK (TO-252) type A footprint <sup>(a)</sup>

a. All dimensions are in millimeters



## 4.2 TO-220FP, STF5N52U



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Table 10. TO-220FP mechanical data						
Dim.	mm					
	Min.	Тур.	Max.			
A	4.4		4.6			
В	2.5		2.7			
D	2.5		2.75			
E	0.45		0.7			
F	0.75		1			
F1	1.15		1.70			
F2	1.15		1.70			
G	4.95		5.2			
G1	2.4		2.7			
Н	10		10.4			
L2		16				
L3	28.6		30.6			
L4	9.8		10.6			
L5	2.9		3.6			
L6	15.9		16.4			
L7	9		9.3			
Ø	3		3.2			

Table 10. TO-220FP mechanical data



## 5 Packaging mechanical data

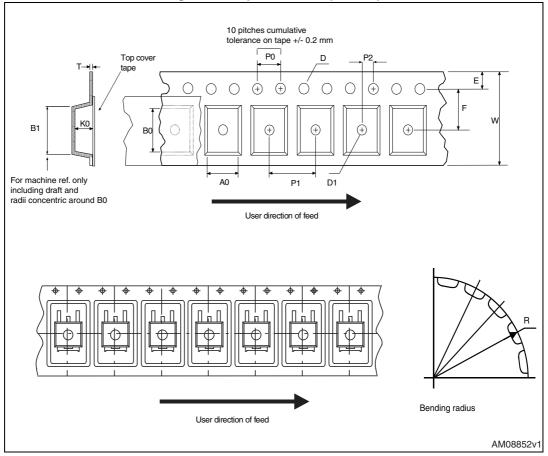


Figure 25. Tape for DPAK (TO-252)



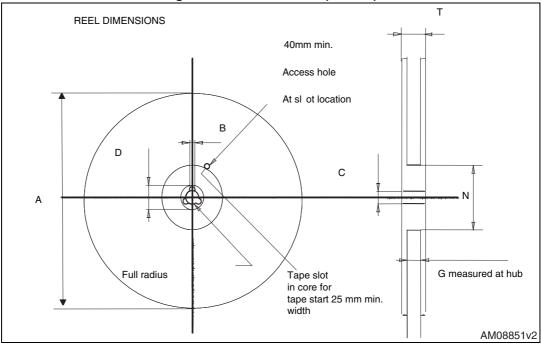


Figure 26. Reel for DPAK (TO-252)

Таре				Reel			
Dim	mm			mm			
Dim. —	Min.	Max.	— Dim.	Min.	Max.		
A0	6.8	7	А		330		
B0	10.4	10.6	В	1.5			
B1		12.1	С	12.8	13.2		
D	1.5	1.6	D	20.2			
D1	1.5		G	16.4	18.4		
Е	1.65	1.85	N	50			
F	7.4	7.6	Т		22.4		
K0	2.55	2.75					
P0	3.9	4.1		Base qty.	2500		
P1	7.9	8.1		Bulk qty.	2500		
P2	1.9	2.1			•		
R	40						

### Table 11. DPAK (TO-252) tape and reel mechanical data



Т

W

0.25

15.7

0.35

16.3

## 6 Revision history

Date	Revision	Changes
06-May-2009	1	First release.
28-Sep-2011	2	<ul> <li>Inserted new device in I<sup>2</sup>PAK.</li> <li>Updated tables 1, 2 and 3 with the new package.</li> <li>Updated Section 4: Package mechanical data with the new package and Section 5: Packaging mechanical data.</li> <li>Minor text changes.</li> </ul>
24-Apr-2014	3	<ul> <li>Updated Section 4.1: DPAK, STD5N52U</li> <li>Modified: Q<sub>rr</sub> unit in Table 7</li> <li>Modified: Figure 8 and 11</li> <li>The part number STI5N52U has been moved to a separate datasheet</li> </ul>



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